


<b>Search Notes</b>  	<b>Application/Control No.</b>  110732854	<b>Applicant(s)/Patent Under Reexamination</b>  HUGL ET AL.
	<b>Examiner</b>  RICHARD CHAN	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
375	224	7/18/08	RC
455	101, 103	7/18/08	RC

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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